

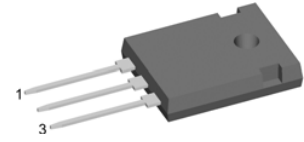
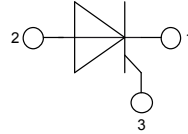
# High Efficiency Thyristor

Single Thyristor

$V_{RRM} = 1200\text{ V}$   
 $I_{T(AV)M} = 50\text{ A}$   
 $I_{T(RMS)} = 79\text{ A}$

Part number

**CLA 50 E 1200 HB**



Backside: anode

**Features / Advantages:**

- Thyristor for line frequency
- Planar passivated chip
- Long-term stability

**Applications:**

- Softstart AC motor control
- DC Motor control
- Power converter
- AC power control
- Lighting and temperature control

**Package:**

- Housing: TO-247
- Industry standard outline
- Epoxy meets UL 94V-0
- RoHS compliant

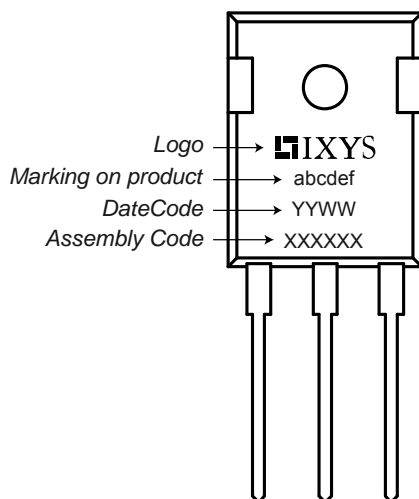
Symbol	Definition	Conditions	Ratings			Unit
			min.	typ.	max.	
$V_{RSMDSM}$	max. non-repetitive reverse/forward blocking voltage				1300	V
$V_{RRM/DRM}$	max. repetitive reverse/forward blocking voltage				1200	V
$I_{R/D}$	reverse current, drain current	$V_{R/D} = 1200\text{ V}$			50	$\mu\text{A}$
		$V_{R/D} = 1200\text{ V}$			4	mA
$V_T$	forward voltage drop	$I_T = 50\text{ A}$			1.32	V
		$I_T = 100\text{ A}$			1.60	V
		$I_T = 50\text{ A}$			1.27	V
		$I_T = 100\text{ A}$			1.65	V
$I_{T(AV)M}$	average forward current	$T_C = 125^\circ\text{C}$			50	A
$I_{T(RMS)}$	RMS forward current	180° sine			79	A
$V_{TO}$	threshold voltage	} for power loss calculation only			0.88	V
$r_T$	slope resistance				7.7	m $\Omega$
$R_{thJC}$	thermal resistance junction to case				0.25	K/W
$T_{VJ}$	virtual junction temperature		-40		150	$^\circ\text{C}$
$P_{tot}$	total power dissipation				500	W
$P_{GM}$	max. gate power dissipation	$t_p = 30\ \mu\text{s}$			10	W
		$t_p = 300\ \mu\text{s}$			1	W
$P_{GAV}$	average gate power dissipation				0.5	W
$I_{TSM}$	max. forward surge current	$t = 10\text{ ms}; (50\text{ Hz}), \text{ sine}$	$T_{VJ} = 45^\circ\text{C}$		550	A
		$t = 8,3\text{ ms}; (60\text{ Hz}), \text{ sine}$	$V_R = 0\text{ V}$		595	A
		$t = 10\text{ ms}; (50\text{ Hz}), \text{ sine}$	$T_{VJ} = 150^\circ\text{C}$		470	A
		$t = 8,3\text{ ms}; (60\text{ Hz}), \text{ sine}$	$V_R = 0\text{ V}$		505	A
$I^2t$	value for fusing	$t = 10\text{ ms}; (50\text{ Hz}), \text{ sine}$	$T_{VJ} = 45^\circ\text{C}$		1.52	kA <sup>2</sup> s
		$t = 8,3\text{ ms}; (60\text{ Hz}), \text{ sine}$	$V_R = 0\text{ V}$		1.48	kA <sup>2</sup> s
		$t = 10\text{ ms}; (50\text{ Hz}), \text{ sine}$	$T_{VJ} = 150^\circ\text{C}$		1.11	kA <sup>2</sup> s
		$t = 8,3\text{ ms}; (60\text{ Hz}), \text{ sine}$	$V_R = 0\text{ V}$		1.06	kA <sup>2</sup> s
$C_J$	junction capacitance	$V_R = 400\text{ V}$ $f = 1\text{ MHz}$	$T_{VJ} = 25^\circ\text{C}$		25	pF

Symbol	Definition	Conditions	Ratings			Unit
			min.	typ.	max.	
$(di/dt)_{cr}$	critical rate of rise of current	$T_{VJ} = 150\text{ °C}$ repetitive, $I_T = 40\text{ A}$ $f = 50\text{ Hz}$ ; $t_p = 200\text{ }\mu\text{s}$ $I = 0.3\text{ A}$ ; $di/dt = 0.3\text{ A}/\mu\text{s}$			150	$\text{A}/\mu\text{s}$
		$V_D = \frac{2}{3} V_{DRM}$ non-repetitive, $I_T = 50\text{ A}$			500	$\text{A}/\mu\text{s}$
$(dv/dt)_{cr}$	critical rate of rise of voltage	$V_D = \frac{2}{3} V_{DRM}$ $T_{VJ} = 150\text{ °C}$ $R_{GK} = \infty$ ; method 1 (linear voltage rise)			1000	$\text{V}/\mu\text{s}$
$V_{GT}$	gate trigger voltage	$V_D = 6\text{ V}$ $T_{VJ} = 25\text{ °C}$ $T_{VJ} = -40\text{ °C}$			1.5	V
$I_{GT}$	gate trigger current	$V_D = 6\text{ V}$ $T_{VJ} = 25\text{ °C}$ $T_{VJ} = -40\text{ °C}$			1.6	V
					50	mA
					80	mA
$V_{GD}$	gate non-trigger voltage	$V_D = \frac{2}{3} V_{DRM}$ $T_{VJ} = 150\text{ °C}$			0.2	V
$I_{GD}$	gate non-trigger current				3	mA
$I_L$	latching current	$t_p = 10\text{ }\mu\text{s}$ $T_{VJ} = 25\text{ °C}$ $I = 0.3\text{ A}$ ; $di/dt = 0.3\text{ A}/\mu\text{s}$			125	mA
$I_H$	holding current	$V_D = 6\text{ V}$ $R_{GK} = \infty$ $T_{VJ} = 25\text{ °C}$			100	mA
$t_{gd}$	gate controlled delay time	$V_D = \frac{1}{2} V_{DRM}$ $T_{VJ} = 25\text{ °C}$ $I = 0.3\text{ A}$ ; $di/dt = 0.3\text{ A}/\mu\text{s}$			2	$\mu\text{s}$
$t_q$	turn-off time	$V_R = 100\text{ V}$ ; $I_T = 33\text{ A}$ $T_{VJ} = 150\text{ °C}$ $V_D = \frac{2}{3} V_{DRM}$ ; $t_p = 200\text{ }\mu\text{s}$ $di/dt = 10\text{ A}/\mu\text{s}$ ; $dv/dt = 20\text{ V}/\mu\text{s}$		200		$\mu\text{s}$

Symbol	Definition	Conditions	Ratings			Unit
			min.	typ.	max.	
$I_{RMS}$	RMS current	per terminal			70	A
$R_{thCH}$	thermal resistance case to heatsink			0.25		K/W
$T_{stg}$	storage temperature		-55		150	°C
<b>Weight</b>				6		g
$M_D$	mounting torque		0.8		1.2	Nm
$F_c$	mounting force with clip		20		120	N

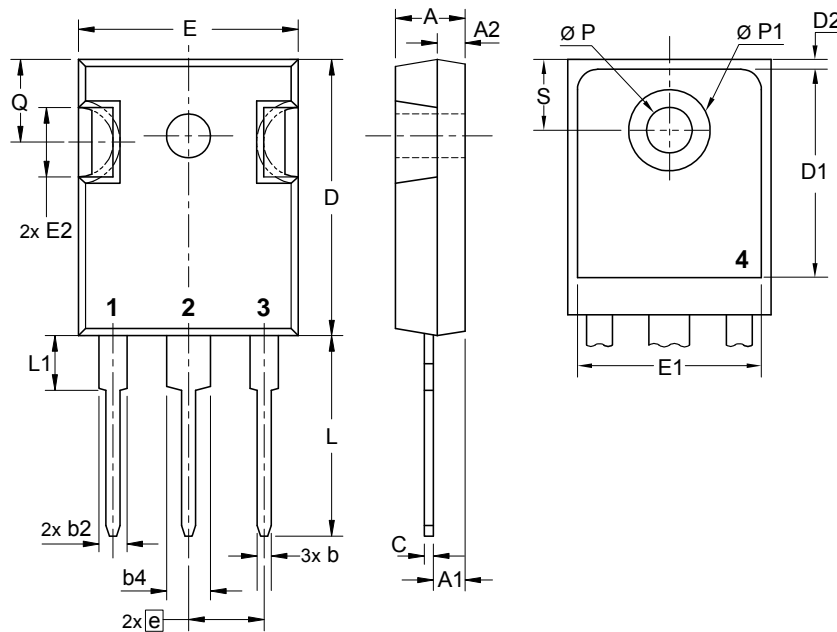
**Part number**

C = Thyristor (SCR)  
 L = High Efficiency Thyristor  
 A = (up to 1200 V)  
 50 = Current Rating [A]  
 E = Single Part  
 1200 = Reverse Voltage [V]  
 HB = TO-247AD (3)

**Product Marking**


Ordering	Part Name	Marking on Product	Delivering Mode	Base Qty	Code Key
Standard	CLA 50 E 1200 HB	CLA50E1200HB	Tube	30	503748

Similar Part	Package	Voltage class
CLA50E1200TC	TO-268AA (D3Pak)	1200

**Outlines TO-247**


Sym.	Inches		Millimeter	
	min.	max.	min.	max.
A	0.185	0.209	4.70	5.30
A1	0.087	0.102	2.21	2.59
A2	0.059	0.098	1.50	2.49
D	0.819	0.845	20.79	21.45
E	0.610	0.640	15.48	16.24
E2	0.170	0.216	4.31	5.48
e	0.215 BSC		5.46 BSC	
L	0.780	0.800	19.80	20.30
L1	-	0.177	-	4.49
Ø P	0.140	0.144	3.55	3.65
Q	0.212	0.244	5.38	6.19
S	0.242 BSC		6.14 BSC	
b	0.039	0.055	0.99	1.40
b2	0.065	0.094	1.65	2.39
b4	0.102	0.135	2.59	3.43
c	0.015	0.035	0.38	0.89
D1	0.515	-	13.07	-
D2	0.020	0.053	0.51	1.35
E1	0.530	-	13.45	-
Ø P1	-	0.29	-	7.39

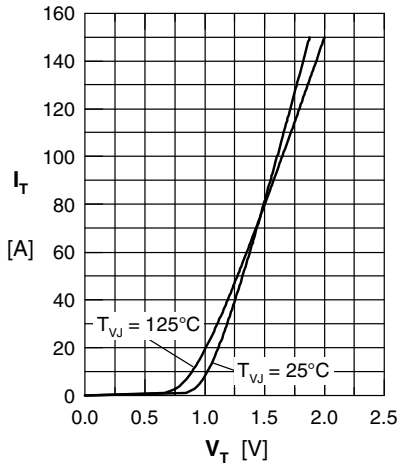


Fig. 1 Forward characteristics

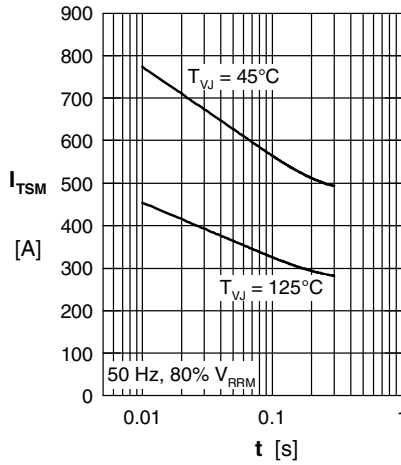


Fig. 2 Surge overload current

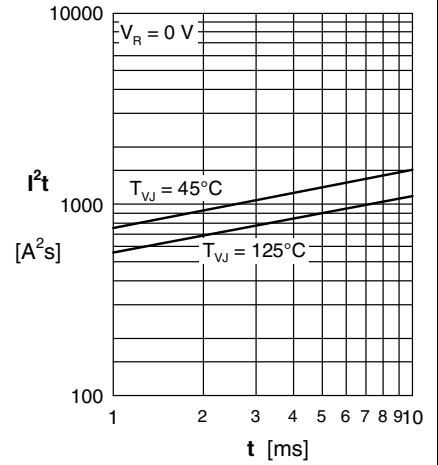


Fig. 3  $I^2t$  versus time (1-10 ms)

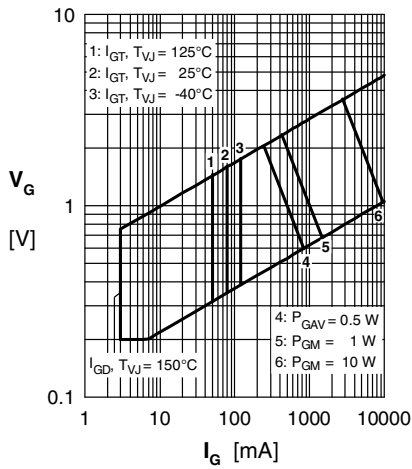


Fig. 4 Gate trigger characteristics

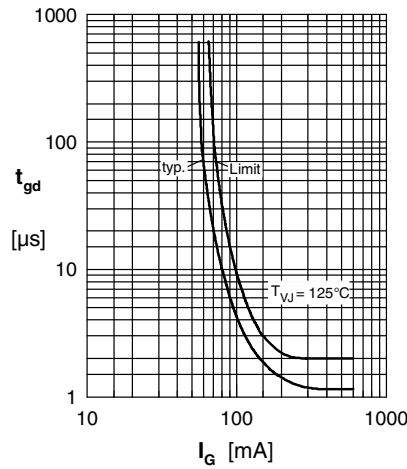


Fig. 5 Gate controlled delay time  $t_{gd}$

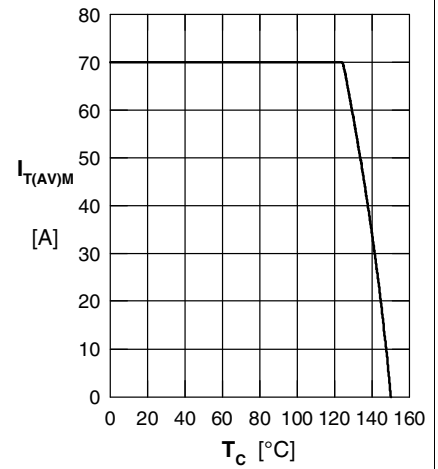


Fig. 6 Max. forward current at case temperature

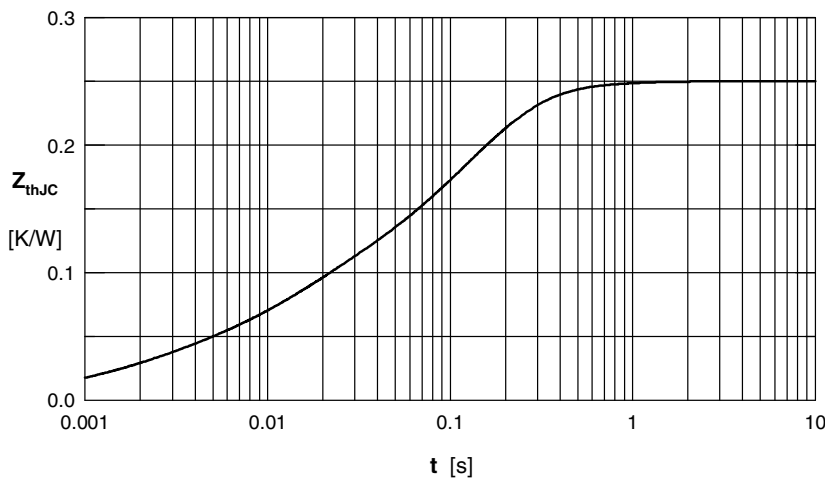


Fig. 7 Transient thermal impedance junction to case

$R_i$	$\tau_i$
0.0075	0.0011
0.017	0.0019
0.057	0.0115
0.158	0.12
0.0105	0.5